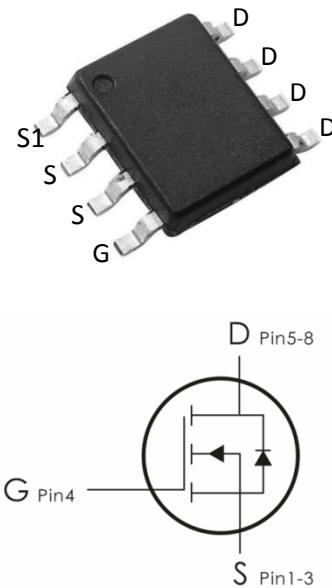


Description:

This N-Channel MOSFET uses advanced trench technology and design to provide excellent $R_{DS(on)}$ with low gate charge. It can be used in a wide variety of applications.

Features:

- 1) $V_{DS}=30V, I_D=10.3A, R_{DS(on)}<8m\Omega @ V_{GS}=10V$
- 2) Low gate charge.
- 3) Green device available.
- 4) Advanced high cell density trench technology for ultra low $R_{DS(on)}$.
- 5) Excellent package for good heat dissipation.



Absolute Maximum Ratings: ($T_c=25^\circ C$ unless otherwise noted)

Symbol	Parameter	Ratings	Units
V_{DS}	Drain-Source Voltage	30	V
V_{GS}	Gate-Source Voltage	± 20	V
I_D	Drain Current -Continuous ¹ ($T_A=25^\circ C$)	10.3	A
	Drain Current -Continuous ¹ ($T_A=70^\circ C$)	8.2	
I_{DM}	Drain Current – Pulsed ²	42	
E_{AS}	Single Pulse Avalanche Energy ³	61	mJ
I_{AS}	Avalanche Current	35	A
P_D	Power Dissipation ⁴ ($T_A=25^\circ C$)	1.5	W
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +150	°C

Thermal Characteristics:

Symbol	Parameter	Max	Units
R_{eJC}	Thermal Resistance,Junction to Case ¹	36	°C/W
R_{eJA}	Thermal Resistance,Junction to Ambient ¹	85	

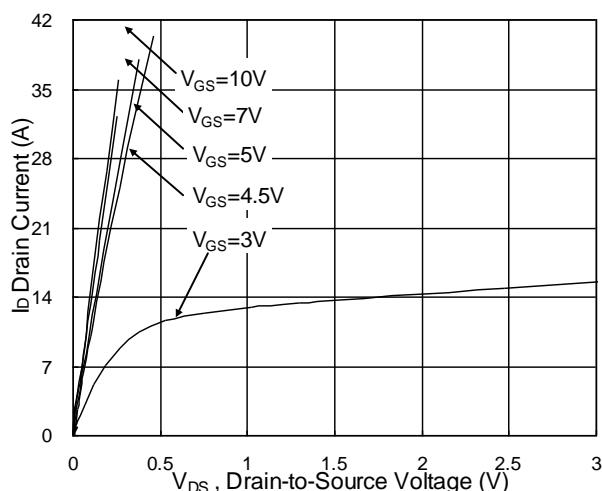
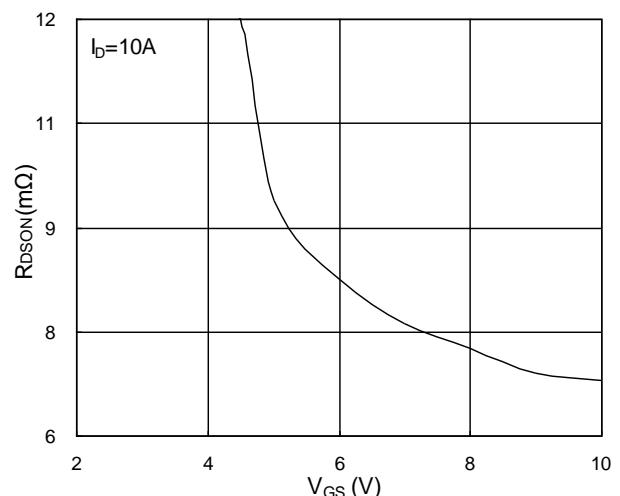
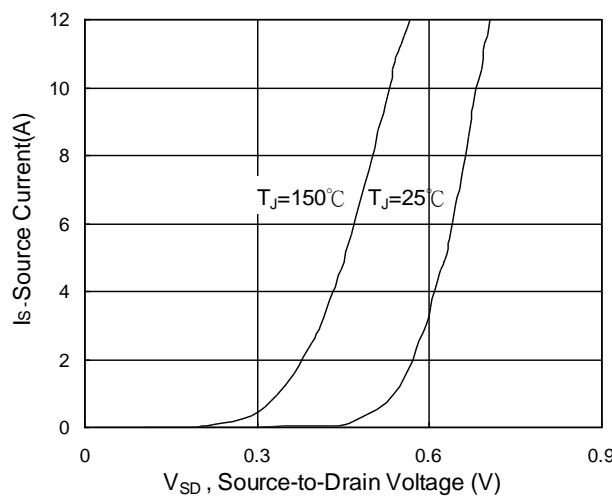
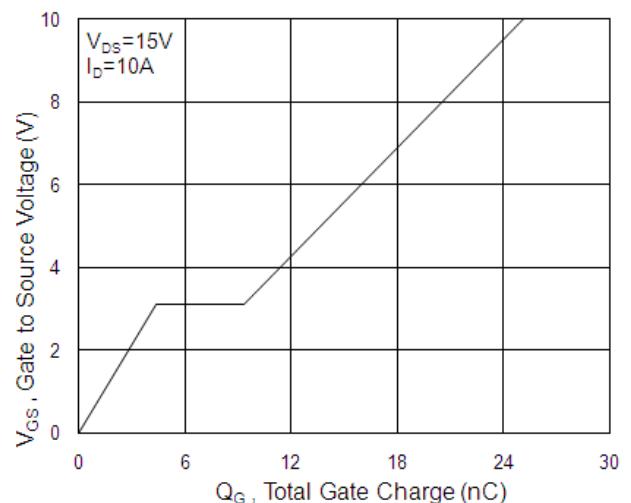
Electrical Characteristics: ($T_C=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=250 \mu\text{A}$	30	---	---	V
I_{DSS}	Drain-Source Leakage Current	$V_{DS}=24\text{V}, V_{GS}=0\text{V}, T_J=25^\circ\text{C}$	---	---	1	μA
		$V_{DS}=24\text{V}, V_{GS}=0\text{V}, T_J=55^\circ\text{C}$	---	---	5	μA
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 20\text{V}, V_{DS}=0\text{V}$	---	---	± 100	nA
On Characteristics³						
$V_{GS(\text{th})}$	GATE-Source Threshold Voltage	$V_{GS}=V_{DS}, I_D=250 \mu\text{A}$	1.2	1.5	2.5	V
$R_{DS(\text{ON})}$	Static Drain-Source On Resistance ²	$V_{GS}=10\text{V}, I_D=10\text{A}$	---	7	8	$\text{m}\Omega$
		$V_{GS}=4.5\text{V}, I_D=8\text{A}$	---	11	14	$\text{m}\Omega$
G_{FS}	Forward Transconductance	$V_{DS}=5\text{V}, I_D=10\text{A}$	---	5.8	---	S
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{DS}=15\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$	---	1300	1840	pF
C_{oss}	Output Capacitance		---	160	225	
C_{rss}	Reverse Transfer Capacitance		---	130	180	
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	$V_{DD}=15\text{V}, I_D=10\text{A}$	---	6.2	12.4	ns
t_r	Rise Time		---	59	106	ns
$t_{d(off)}$	Turn-Off Delay Time		---	27.6	55	ns
t_f	Fall Time		---	8.4	16.8	ns
Q_g	Total Gate Charge		---	12.6	17.6	nC
Q_{gs}	Gate-Source Charge	$V_{GS}=4.5\text{V}, V_{DS}=15\text{V}, I_D=10\text{A}$	---	4.2	5.9	nC
Q_{gd}	Gate-Drain "Miller" Charge		---	5.1	7.1	nC
R_G	Gate Resistance	Gate Resistance	---	2.2	3.8	Ω

Drain-Source Diode Characteristics						
V_{SD}	Source-Drain Diode Forward Voltage ²	$V_{GS}=0V, I_S=1A, T_J=25^\circ C$	---	---	1.2	V
I_S	Continuous Source Current ^{1,5}	$V_G=V_D=0V$, Force Current	---	---	10.3	A
I_{SM}	Pulsed Source Current ^{2,5}		---	---	42	A
T_{rr}	Body Diode Reverse Recovery Time	$I_F=10A, dI/dt=100A/\mu s, T_J=25^\circ C$	---	12.5	---	Ns
Q_{rr}	Body Diode Reverse Recovery Charge		---	5	---	Nc

Notes:

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
- 3.The EAS data shows Max. rating . The test condition is $V_{DD}=25V, V_{GS}=10V, L=0.1mH, I_{AS}=35A$
- 4.The power dissipation is limited by $150^\circ C$ junction temperature
- 5.The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

Typical Characteristics: ($T_c=25^\circ C$ unless otherwise noted)

Fig.1 Typical Output Characteristics

Fig.2 On-Resistance vs. Gate-Source

Fig.3 Forward Characteristics of reverse

Fig.4 Gate-Charge Characteristics

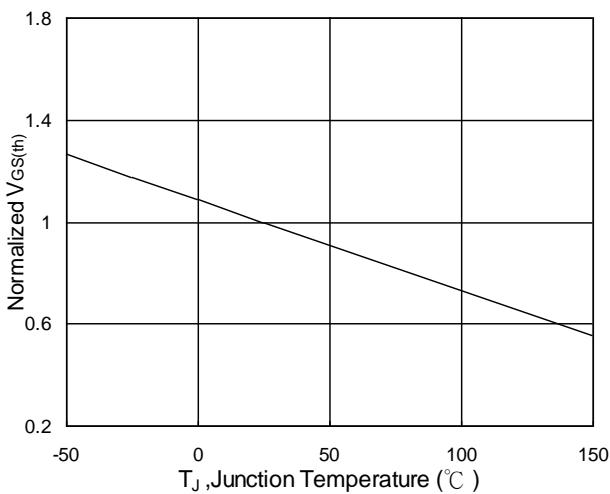


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

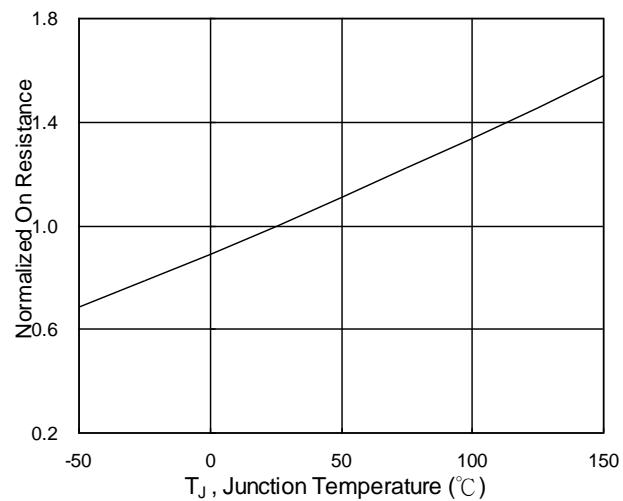


Fig.6 Normalized $R_{DS(on)}$ vs. T_J

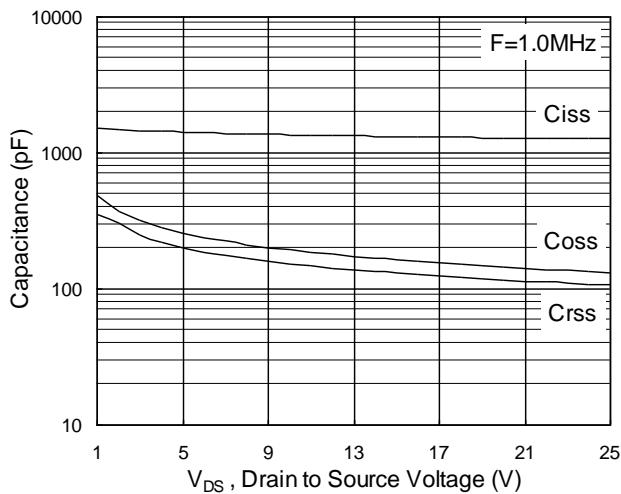


Fig.7 Capacitance

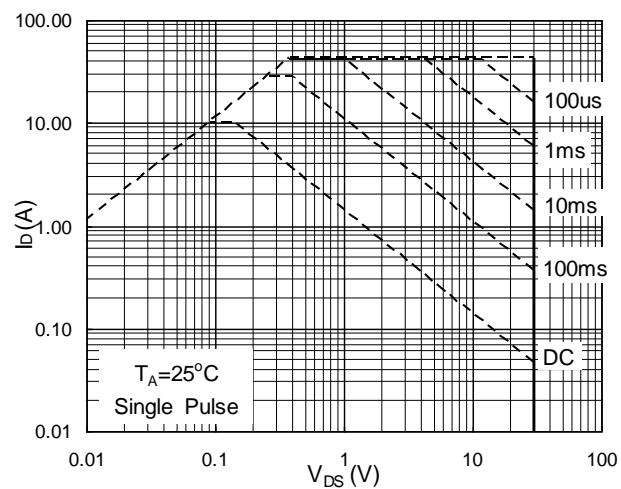


Fig.8 Safe Operating Area

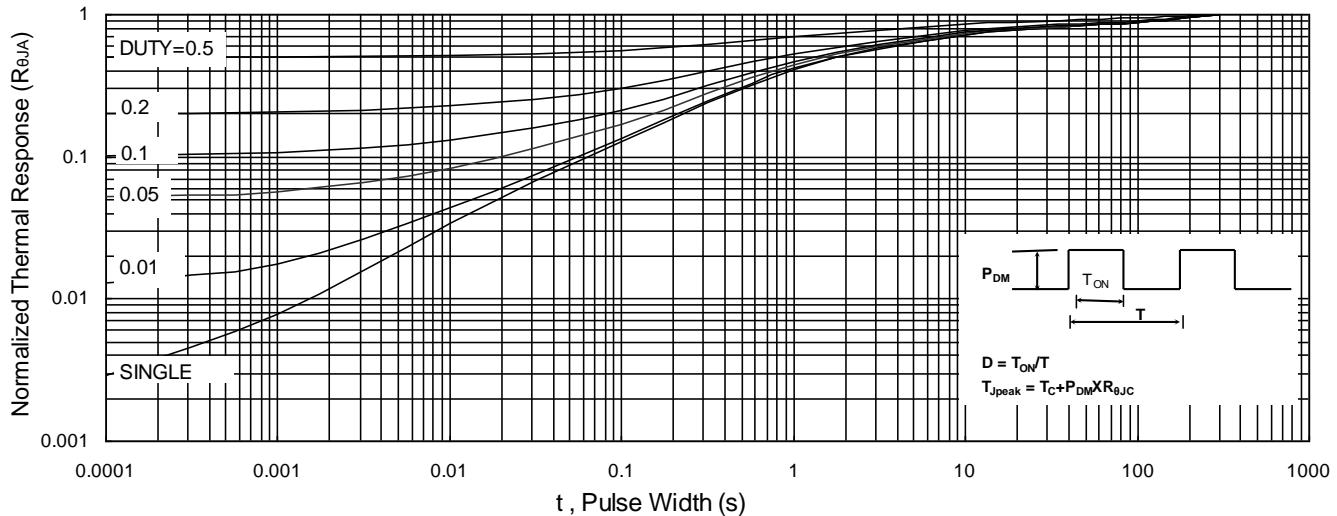


Fig.9 Normalized Maximum Transient Thermal Impedance

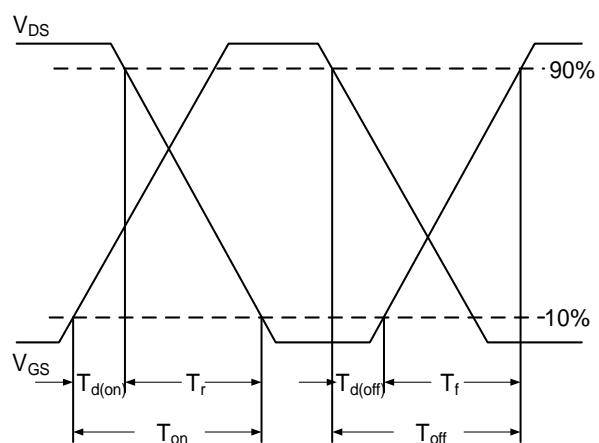


Fig.10 Switching Time Waveform

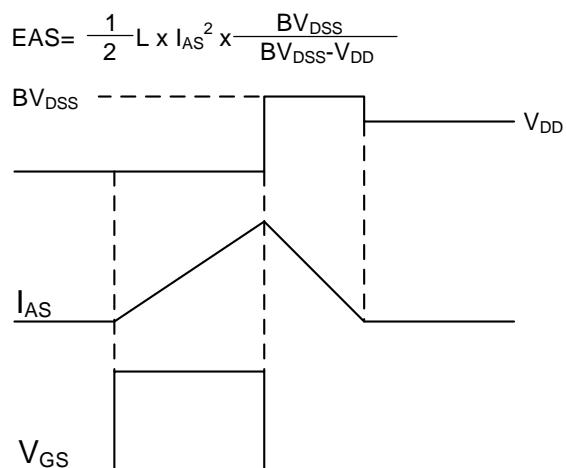


Fig.11 Unclamped Inductive Switching Waveform



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